

Search Notes



Application/Control No.

09/760,154

Examiner

Jamie Vent

Applicant(s)/Patent under Reexamination

TANAKA ET AL.

Art Unit

2621

SEARCHED

Class	Subclass	Date	Examiner
386	83	1/17/2008	JV
386	95		
386	96		
386	109		
386	110		
386	112		
386	46		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
360	46	1/17/08	JV
360	51		
348	470		
H04N	7/26		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Inventor Search	1/17/2008	JV
Claim Search	1/17/2008	JV
Allowance - Consulted - Thai Tran, Bob Chevrier, and Huy Nguyen	1/9/2008	JV